



YEA SHIN TECHNOLOGY CO., LTD

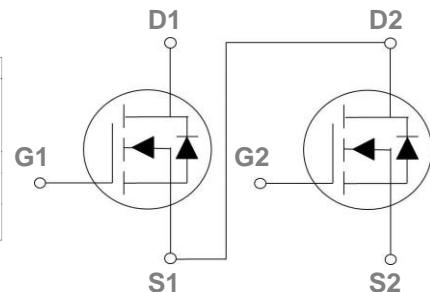
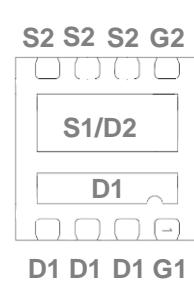
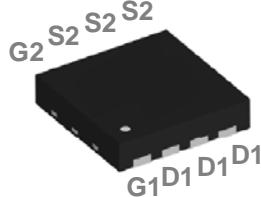
YS3810HCB

Dual N-Channel Enhancement MOSFET

VDS= 30V, ID= 19.5A

**Features**

- Improved dv/dt capability
- Fast switching
- 100% EAS Guaranteed
- Halogen free

DFN3x3 Asymmetric Dual Pin Configuration**Applications**

- MB / VGA / Vcore
- POL Buck Applications
- SMPS 2nd SR

Absolute Maximum Rating Tc=25°C unless otherwise noted

Symbol	Parameter	Rating	Units
V _{DS}	Drain-Source Voltage	30	V
V _{GS}	Gate-Source Voltage	±20	V
I _D	Drain Current – Continuous (Tc=25°C)	19.5	A
	Drain Current – Continuous (Tc=100°C)	12.3	A
	Drain Current – Continuous (TA=25°C)	10.8	A
	Drain Current – Continuous (TA=100°C)	6.8	A
I _{DM}	Drain Current – Pulsed ¹	78	A
EAS	Single Pulse Avalanche Energy ²	13	mJ
IAS	Single Pulse Avalanche Current ²	16	A
P _D	Power Dissipation (TA=25°C)	27	W
	Power Dissipation – Derate above 25°C	0.01	W/°C
T _{STG}	Storage Temperature Range	-55 to 150	°C
T _J	Operating Junction Temperature Range	-55 to 150	°C

Thermal Characteristics

Symbol	Parameter	Typ.	Max.	Unit
R _{θJA}	Thermal Resistance Junction to ambient	---	62	°C/W
R _{θJC}	Thermal Resistance Junction to Case	---	4.6	°C/W

DEVICE CHARACTERISTICS

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Electrical Characteristics ($T_J=25^\circ\text{C}$, unless otherwise noted)

Off Characteristics

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
BV_{DSS}	Drain-Source Breakdown Voltage	$V_{\text{GS}}=0\text{V}$, $I_D=250\mu\text{A}$	30	---	---	V
$\Delta \text{BV}_{\text{DSS}}/\Delta T_J$	BV_{DSS} Temperature Coefficient	Reference to 25°C , $I_D=1\text{mA}$	---	0.04	---	V°C
I_{DSS}	Drain-Source Leakage Current	$V_{\text{DS}}=30\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=25^\circ\text{C}$	---	---	1	μA
		$V_{\text{DS}}=24\text{V}$, $V_{\text{GS}}=0\text{V}$, $T_J=125^\circ\text{C}$	---	---	10	μA
I_{GSS}	Gate-Source Leakage Current	$V_{\text{GS}}=\pm 20\text{V}$, $V_{\text{DS}}=0\text{V}$	---	---	± 100	nA

On Characteristics

$R_{\text{DS(ON)}}$	Static Drain-source On-Resistance ³	$V_{\text{GS}}=10\text{V}$, $I_D=10\text{A}$	---	8.5	10.5	$\text{m}\Omega$
		$V_{\text{GS}}=4.5\text{V}$, $I_D=5\text{A}$	---	11	14	$\text{m}\Omega$
$V_{\text{GS(th)}}$	Gate Threshold Voltage	$V_{\text{GS}}=V_{\text{DS}}$, $I_D=250\mu\text{A}$	1.2	1.6	2.5	V
			---	-4	---	mV°C
g_{fs}	Forward Transconductance	$V_{\text{DS}}=5\text{V}$, $I_D=5\text{A}$	---	12	---	s

Dynamic and Switching Characteristics

Q_g	Total Gate Charge ^{3,4}	$V_{\text{DS}}=15\text{V}$, $V_{\text{GS}}=10\text{V}$, $I_D=5\text{A}$	---	15.6	31	nC
Q_{gs}	Gate-Source Charge ^{3,4}		---	2.3	5	
Q_{gd}	Gate-Drain Charge ^{3,4}		---	3	6	
$T_{\text{d(on)}}$	Turn-On Delay Time ^{3,4}	$V_{\text{DD}}=15\text{V}$, $V_{\text{GS}}=10\text{V}$, $R_{\text{G}}=6\Omega$, $I_D=1\text{A}$	---	3.8	7	ns
T_r	Rise Time ^{3,4}		---	10	19	
$T_{\text{d(off)}}$	Turn-On Delay Time ^{3,4}		---	22	42	
T_f	Fall Time ^{3,4}		---	6.6	13	
C_{iss}	Input Capacitance	$V_{\text{DS}}=25\text{V}$, $V_{\text{GS}}=0\text{V}$, $f=1\text{MHz}$	---	620	900	pF
C_{oss}	Output Capacitance		---	85	125	
C_{rss}	Reverse Transfer Capacitance		---	60	90	
R_g	Gate Resistance	$V_{\text{GS}}=0\text{V}$, $V_{\text{DS}}=0\text{V}$, $f=1\text{MHz}$	---	2.8	5.6	Ω

Drain-Source Diode Characteristics and Maximum Ratings

Symbol	Parameter	Conditions	Min.	Typ.	Max.	Unit
I_s	Continuous Source Current	$V_G=V_D=0\text{V}$, Force Current	---	---	19.5	A
I_{SM}	Pulsed Source Current ³		---	---	39	A
V_{SD}	Diode Forward Voltage ³	$V_{\text{GS}}=0\text{V}$, $I_s=1\text{A}$, $T_J=25^\circ\text{C}$	---	---	1	V

Note :

1. Repetitive Rating : Pulsed width limited by maximum junction temperature.
2. $V_{\text{DD}}=25\text{V}$, $V_{\text{GS}}=10\text{V}$, $L=0.1\text{mH}$, $Q_1:I_{\text{AS}}=16\text{A}$, $Q_2:I_{\text{AS}}=42\text{A}$, $R_{\text{G}}=25\Omega$, Starting $T_J=25^\circ\text{C}$.
3. The data tested by pulsed , pulse width $\leq 300\text{us}$, duty cycle $\leq 2\%$.
4. Essentially independent of operating temperature.

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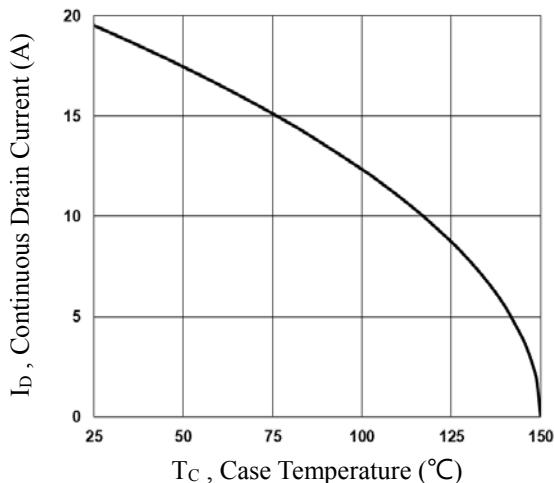


Fig.1 Continuous Drain Current vs. T_c

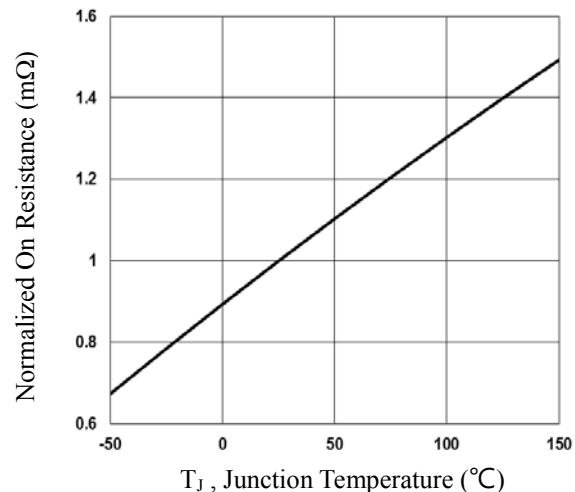


Fig.2 Normalized RDS(on) vs. T_j

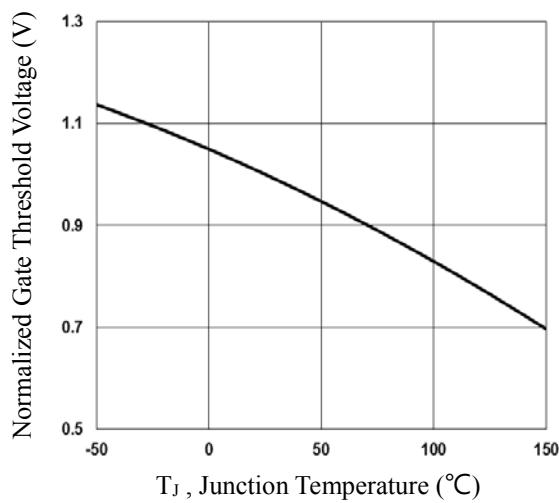


Fig.3 Normalized V_{th} vs. T_j

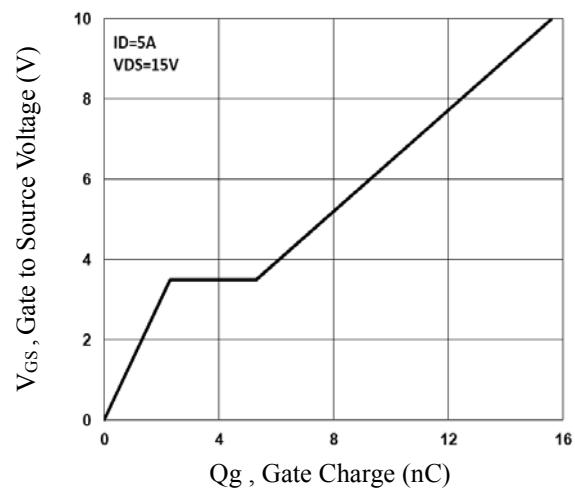


Fig.4 Gate Charge Waveform

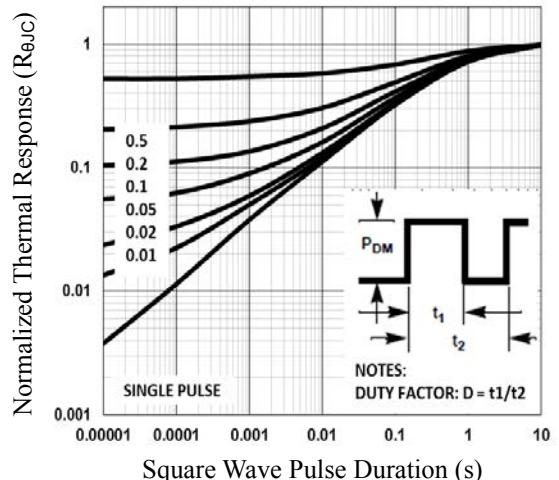


Fig.5 Normalized Transient Impedance

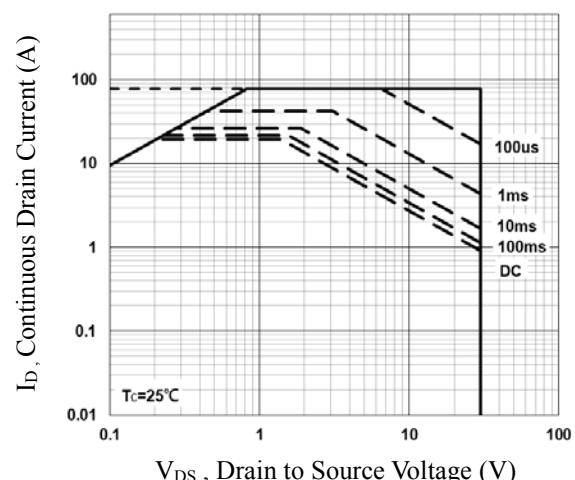


Fig.6 Maximum Safe Operation Area

DEVICE CHARACTERISTICS

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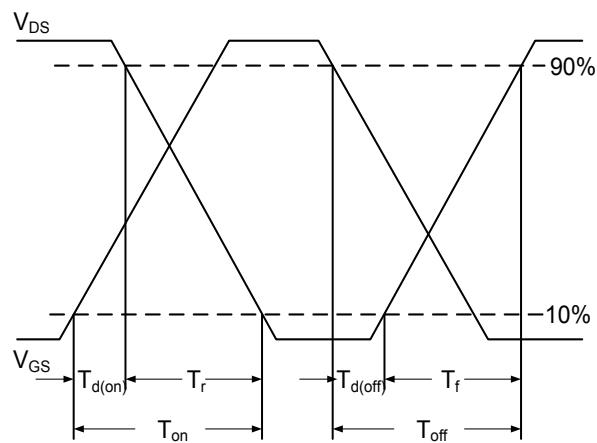


Fig.7 Switching Time Waveform

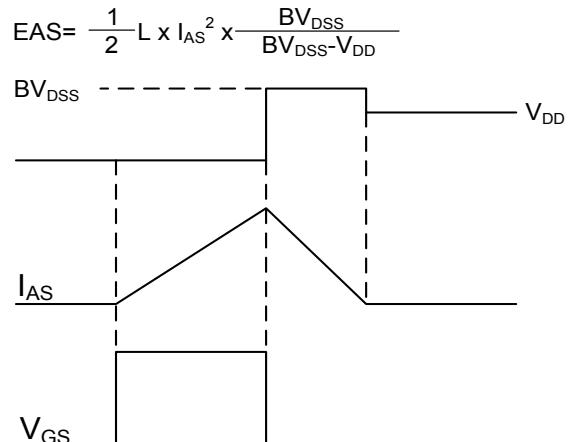
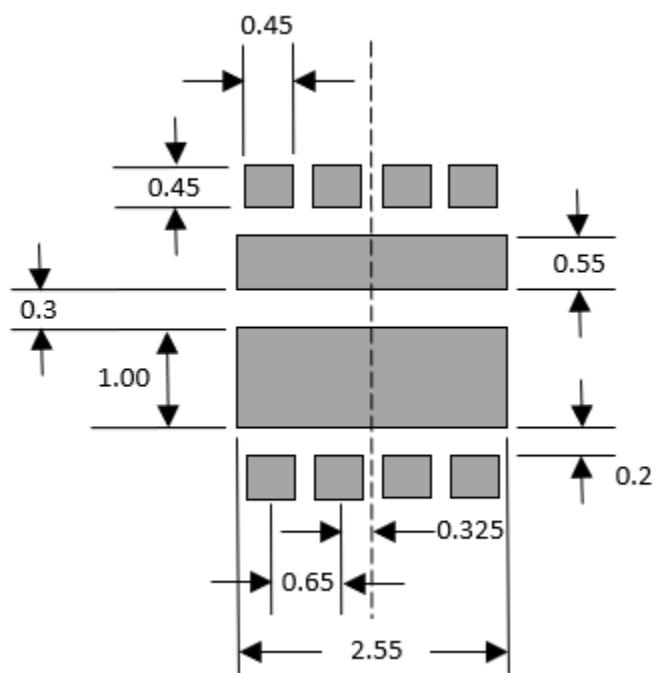


Fig.8 EAS Waveform

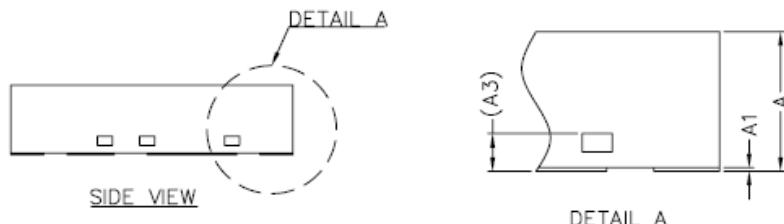
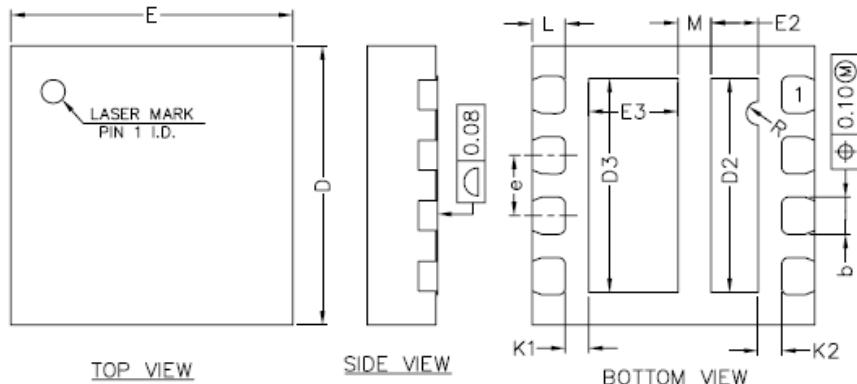
RECOMMEND FOOTPRINT Information



PACKAGE OUTLINE & DIMENSIONS

YS3810HCB

DFN3x3 Asymmetric Dual Package Information



Symbol	Dimensions In Millimeters		
	Min	Typ	Max
A	0.70	0.75	0.80
A1	0.00	0.02	0.05
A3	0.20REF		
b	0.35	0.40	0.45
D	2.90	3.00	3.10
E	2.90	3.00	3.10
D2	2.20	2.30	2.40
E2	0.40	0.50	0.60
D3	2.20	2.30	2.40
E3	0.85	0.95	1.05
e	0.55	0.65	0.75
K1	0.15	0.25	0.35
K2	0.15	0.25	0.35
L	0.30	0.35	0.40
M	0.25	0.35	0.45
R	0.125REF		